

**Search Notes**

Application/Control No.

10/578,317

Examiner

Noah Kamen

Applicant(s)/Patent under  
Reexamination

SHINADA ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	184.53	12/10/2007	/NK/
	184.57		
181	204		
	229		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/10/2007	/NK/